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STW14NM50

N-CHANNEL 550V @ Tjmax - 0.32Ω - 14A TO-247

MDmesh[™] MOSFET

Table 1: General Features

| ТҮРЕ | V_{DSS} (@Tjmax) | R _{DS(on)} | ID |
|-----------|------------------------------------|---------------------|------|
| STW14NM50 | 550 V | < 0.35 Ω | 14 A |

- TYPICAL $R_{DS}(on) = 0.32 \Omega$
- HIGH dv/dt AND AVALANCHE CAPABILITIES
- 100% AVALANCHE RATED
- LOW INPUT CAPACITANCE AND GATE CHARGE
- LOW GATE INPUT RESISTANCE
- TIGHT PROCESS CONTROL AND HIGH MANUFACTORING YIELDS

DESCRIPTION

The MDmesh[™] is a new revolutionary MOSFET technology that associates the Multiple Drain process with the Company's PowerMESH[™] horizontal layout. The resulting product has enoutstanding low on-resistance, impressively high dv/dt and excellent avalanche characteristics. The adoption of the Company's proprierations in technique yields overall dynamic perfermance that is significantly better than that of cimilar completition's products.

APPLICATIONS

The MDmesh™ fam ly is vely suitable for increase the power density of high vo tage converters allowing system miniaturization and higher efficiencies.

| Table 2: Grder Co |
|-------------------|
|-------------------|

| Table 2. Graef Codes | | | |
|----------------------|---------|---------|-----------|
| SALES TYPE | MARKING | PACKAGE | PACKAGING |
| STW14NM50 | W14NM50 | TO-247 | TUBE |

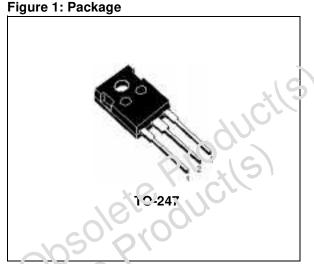


Figure 2: Internel Schematic Diagram

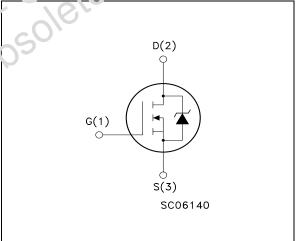


Table 3: Absolute Maximum ratings

| Gate- source Voltage | | |
|---|--|---|
| Cale- Source Vollage | ±30 | V |
| Drain Current (continuous) at T _C = 25°C | 14 | А |
| Drain Current (continuous) at T _C = 100°C | 8.8 | А |
| Drain Current (pulsed) | 56 | А |
| Total Dissipation at $T_C = 25^{\circ}C$ | 175 | W |
| Derating Factor | 1.28 | W/°C |
| Peak Diode Recovery voltage slope | 6 | V/ns |
| Storage Temperature | -65 to 150 | °C |
| Max. Operating Junction Temperature | 150 | °(; |
| ited by safe operating area / maximum temperature allowed $t \le 100A/\mu s, V_{DD} \le V_{(BR)DSS}, T_j \le T_{JMAX}.$ | | 9NCL |
| t | Drain Current (continuous) at T _C = 100°C Drain Current (pulsed) Total Dissipation at T _C = 25°C Derating Factor Peak Diode Recovery voltage slope Storage Temperature Max. Operating Junction Temperature ited by safe operating area maximum temperature allowed | $\begin{array}{l lllllllllllllllllllllllllllllllllll$ |

Table 4: Thermal Data

| Rthj-ca | ise | Thermal Resistance Junction-case Max | 0.715 | °C/W |
|----------------|-----|--|-------|------|
| Rthj-a | nb | Thermal Resistance Junction-ambient Max | 30 | °C/W |
| Τ _Ι | | Maximum Lead Temperature For Soldering Purpose | 300 | °C |

Table 5: Avalanche Characteristics

| Symbol | Parameter | Max Value | Unit |
|-----------------|---|-----------|------|
| I _{AR} | Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T _j max) | 12 | А |
| E _{AS} | Single Pulse Avalanche Energy (starting $T_j = 25 \text{ °C}, I_D = I_{Ai}, V_{DD} = 50 \text{ V}$) | 400 | mJ |

ELECTRICAL CHARACTERISTIC: (TCASE = 25°C UNLESS OTHERWISE SPECIFIED) Table 6: On /Off 15

| Symbol | I Parameter Test Conditions M | | Min. | Тур. | Max. | Unit |
|----------------------|---|--|------|------|---------|----------|
| V _{(BR)DSS} | Drain si uire Breakdown Valtuga | $I_{D} = 250 \ \mu A, \ V_{GS} = 0$ | 500 | | | V |
| IDSS | ວເວ Gate Voltage Drain Current (V _{GS} = 0) | V_{DS} = Max Rating V_{DS} = Max Rating, T _C = 125°C | | | 1 10 | μΑ μΑ |
| IGeg | Gate-body Leakage Current (V _{DS} = 0) | V _{GS} = ± 30 V | | | ± 100 | nA |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = 250 \ \mu A$ | 3 | 4 | 5 | V |
| RDS(on | Static Drain-source On Resistance | V _{GS} = 10 V, I _D = 6 A | | 0.32 | 0.35 | Ω |

ELECTRICAL CHARACTERISTICS (CONTINUED)

Table 7: Dynamic

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|---|--|--|------|---------------------|------|----------------------|
| g _{fs} (1) | Forward Transconductance | | | 5.2 | | S |
| C _{iss} C _{oss} C _{rss} | Input Capacitance Output Capacitance Reverse Transfer Capacitance | V_{DS} = 25 V, f = 1 MHz, V_{GS} = 0 | | 1000 180 25 | | pF pF pF |
| C _{OSS eq} (3). | Equivalent Output Capacitance | $V_{GS} = 0 V, V_{DS} = 0 to 400 V$ | | 90 | | pF |
| R _G | Gate Input Resistance | f=1 MHz Gate DC Bias = 0 Test Signal Level = 20mV Open Drain | | 1.6 | | Ω |
| t _{d(on)} t _r t _{d(off)} t _f | Turn-on Delay Time Rise Time Turn-off-Delay Time Fall Time | | | 20 10 19 8 | 000 | ns ns ns ns |
| Q _g Q _{gs} Q _{gd} | Total Gate Charge Gate-Source Charge Gate-Drain Charge | $V_{DD} = 400 \text{ V}, I_D = 12 \text{ A}, V_{GS} = 10 \text{ V}$ (see Figure 18) | X | 28 8 15 | 38 | nC nC nC |

Table 8: Source Drain Diode

| Symbol | Parameter | Test Condi ions | Min. | Тур. | Max. | Unit |
|--|--|--|------|---------------------|----------|---------------|
| I _{SD} I _{SDM} (2) | Source-drain Current Source-drain Current (pulsed) | 10 | 6 | | 14 56 | A A |
| V _{SD} (1) | Forward On Voltage | ISD = 12 P, VGS = 0 | | | 1.5 | V |
| t _{rr} Q _{rr} I _{RRM} | Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current | ' _{SD} = 1≥ A, di/dt = 100 A/μs V _{DD} = 100V (see Figure 16) | | 270 2.23 16.5 | | ns μC Α |
| t _{rr} Q _{rr} I _{RRM} | Reverse Recover / Time Reverse Recovery Charge Reverse Fielovery Current | $I_{SD} = 12 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 100\text{V}, \text{ T}_{j} = 150^{\circ}\text{C}$ (see Figure 16) | | 340 3 18 | | ns μC Α |

Josofiled 3

(1) Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %.
(2) Pulse width limited by safe operating area.
(3) C_{oss eq.} is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}.

Figure 3: Safe Operating Area

HV21150 $I_D(A)$ 10² 10µs 10¹ 100µs 1ms 10ms 10[°] -----Tj=150°C Tc=25°C D.C. OPERATION Single pulse 10 10^{1²} 1° 103 V_{DS}(V) 10^{-1} 10²

Figure 4: Output Characteristics

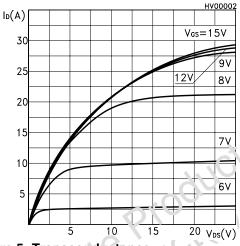


Figure 5: Transcor. Instance

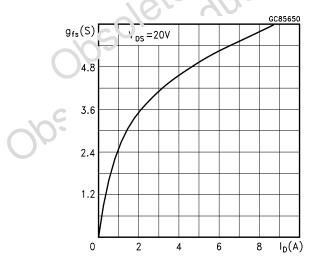


Figure 6: Thermal Impedance

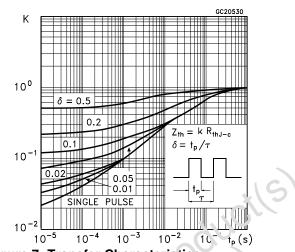


Figure 7: Transfer Characteristics

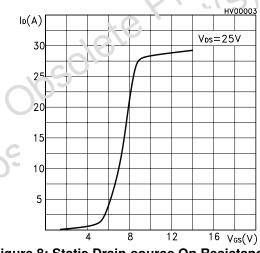


Figure 8: Static Drain-source On Resistance

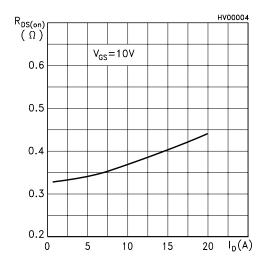


Figure 9: Gate Charge vs Gate-source Voltage

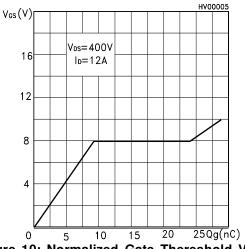


Figure 10: Normalized Gate Thereshold Voltage vs Temperature

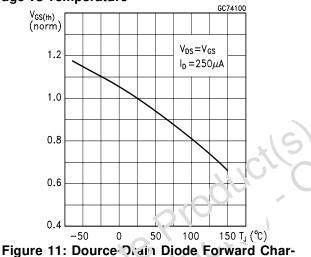


Figure 11: Dource D. ain acteristics

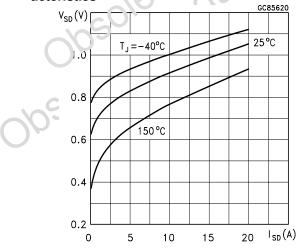


Figure 12: Capacitance Variations

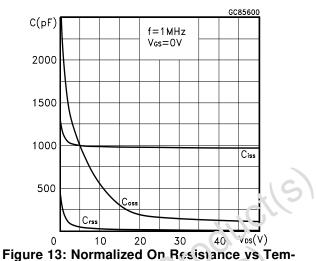


Figure 13: Normalized On Resistance vs Temperature

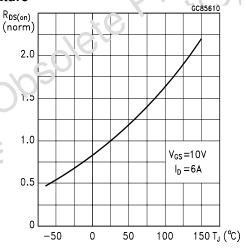


Figure 14: Unclamped Inductive Load Test Circuit

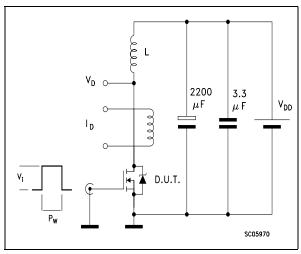


Figure 15: Switching Times Test Circuit For Resistive Load

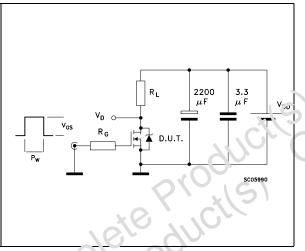


Figure 16. Sest Circuit For Inductive Load Switching and Diode Recovery Times

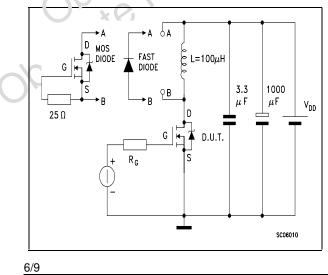


Figure 17: Unclamped Inductive Wafeform

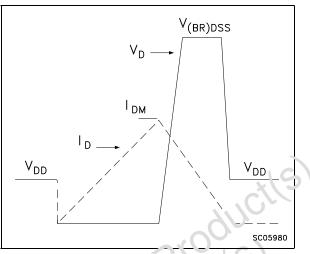
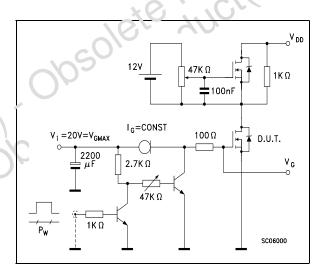


Figure 18: Gate Charge Test Circuit



| DIM. | | mm. | | | inch | |
|------|-------|-------|-------|-------|-------|-------|
| | MIN. | ТҮР | MAX. | MIN. | TYP. | MAX. |
| А | 4.85 | | 5.15 | 0.19 | | 0.20 |
| A1 | 2.20 | | 2.60 | 0.086 | | 0.102 |
| b | 1.0 | | 1.40 | 0.039 | | 0.055 |
| b1 | 2.0 | | 2.40 | 0.079 | | 0.094 |
| b2 | 3.0 | | 3.40 | 0.118 | | 0.134 |
| С | 0.40 | | 0.80 | 0.015 | | 0.03 |
| D | 19.85 | | 20.15 | 0.781 | | 0.793 |
| E | 15.45 | | 15.75 | 0.608 | | 0.620 |
| е | | 5.45 | | | 0.214 | 201 |
| L | 14.20 | | 14.80 | 0.560 | | 0.582 |
| L1 | 3.70 | | 4.30 | 0.14 | × C. | 0.17 |
| L2 | | 18.50 | | | 0722 | |
| øР | 3.55 | | 3.65 | 0.140 | | 0.143 |
| øR | 4.50 | | 5.50 | 0.177 | | 0.216 |
| S | | 5.50 | | | 0.216 | |



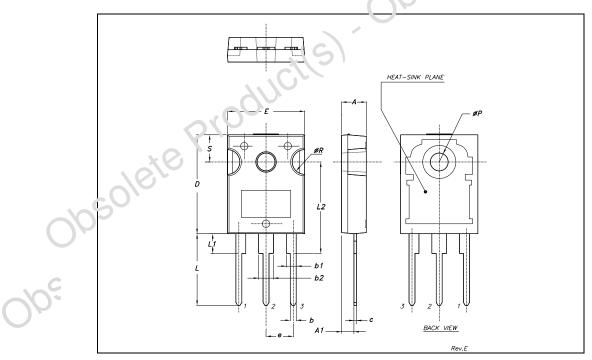


Table 9: Revision History

| Date | Revision | Description of Changes | |
|--------------|----------|---|--|
| 05-July-2004 | 5 | The document change from "PRELIMINARY" to "COMPLETE". | |
| | | New Stylesheet. | |

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